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(54) Title: CLOSED CHAMBER WITH FLUID SEPARATION FEATURE

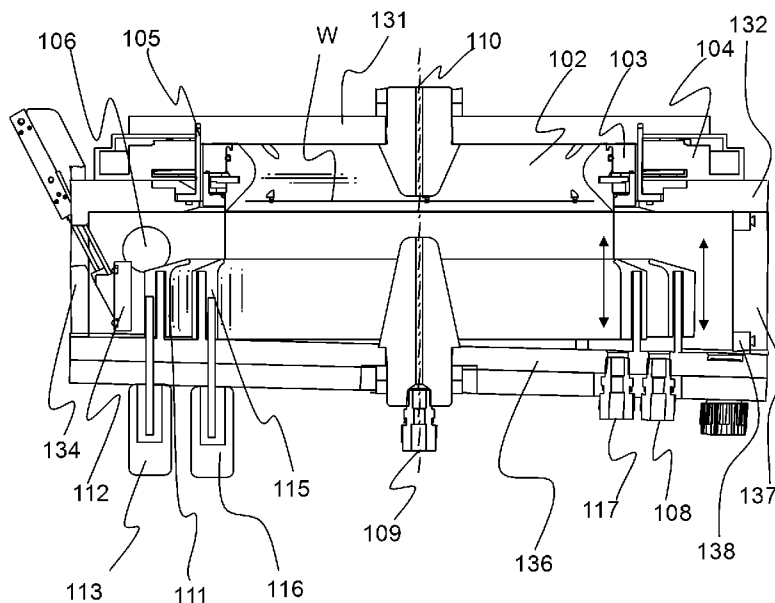


Fig. 1a

(57) Abstract: Selective recovery of excess process fluid from within a closed process chamber is achieved by providing a magnetically drive ring chuck and at least one process fluid collector within the closed process chamber, with the ring chuck and the fluid collector being vertically movable relative to each other.



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Description

Title of Invention: CLOSED CHAMBER WITH FLUID SEPARATION FEATURE

BACKGROUND OF THE INVENTION

1. Field of the Invention

[0001] The invention relates generally to an apparatus for treating surfaces of wafer-shaped articles, such as semiconductor wafers, wherein one or more treatment fluids may be recovered from within a closed process chamber.

2. Description of Related Art

[0002] Semiconductor wafers are subjected to various surface treatment processes such as etching, cleaning, polishing and material deposition. To accommodate such processes, a single wafer may be supported in relation to one or more treatment fluid nozzles by a chuck associated with a rotatable carrier, as is described for example in U.S. Patent Nos. 4,903,717 and 5,513,668.

[0003] Alternatively, a chuck in the form of a ring rotor adapted to support a wafer may be located within a closed process chamber and driven without physical contact through an active magnetic bearing, as is described for example in International Publication No. WO 2007/101764 and U.S. Patent No. 6,485,531. Treatment fluids which are driven outwardly from the edge of a rotating wafer due to centrifugal action are delivered to a common drain for disposal.

SUMMARY OF THE INVENTION

[0004] The present inventors have discovered that, in chucks of the type described above, various treatment fluids may advantageously be separately recovered from within a closed process chamber so that the recovered fluids may be recycled or reused.

[0005] According to the present invention, a device for holding wafer-shaped articles, such as semiconductor wafers, within a closed process chamber is equipped with two or more distinct fluid collectors, wherein the wafer support and fluid collectors are movable relative to each other via a magnetic coupling which is actuated from outside of the closed process chamber, such that process fluid emanating from the wafer surface can be selectively directed to a given fluid outlet.

BRIEF DESCRIPTION OF THE DRAWINGS

[0006] Other objects, features and advantages of the invention will become more apparent after reading the following detailed description of preferred embodiments of the invention, given with reference to the accompanying drawings, in which:

- [0007] Figure 1a is a cross-sectional side view of a process chamber according to an embodiment of the invention, shown in a wafer loading/unloading status;
- [0008] Figure 1b is a cross-sectional perspective view of the process chamber of Figure 1a;
- [0009] Figure 1c is a cross-sectional perspective view of the process chamber of Figure 1a, shown in a first process fluid collection status;
- [0010] Figure 1d is a cross-sectional perspective view of the process chamber of Figure 1a, shown in a second process fluid collection status;
- [0011] Figure 1e is a cross-sectional perspective view of the process chamber of Figure 1a, shown in an alternative second process fluid collection status;
- [0012] Figure 1f is a partial cross-sectional perspective view of a process chamber according to another embodiment of the invention;
- [0013] Figure 1g is an enlarged sectional view of a preferred fluid collector profile and drive assembly;
- [0014] Figure 2a is a cross-sectional perspective view of a process chamber according to another embodiment of the invention;
- [0015] Figure 2b is a cross-sectional view of the process chamber of Figure 2a;
- [0016] Figure 2c is a cross-sectional perspective view of the process chamber of Figure 2a, shown in a first process fluid collection status; and
- [0017] Figure 2d is a cross-sectional perspective view of the process chamber of Figure 2a, shown in a second process fluid collection status.

DETAILED DESCRIPTION OF PREFERRED EMBODIMENTS

- [0018] Referring to Figures 1a and 1b, a closed process chamber is defined by an upper chamber having an open bottom region which is seated atop a larger lower chamber having an open top region, as is described in further detail below.
- [0019] The perimeter of the upper chamber is defined by a cylindrical chamber wall (105). The cylindrical chamber wall (105) comprises a vertically oriented cylindrical wall having an upper end and an outwardly extending radial flange at its lower end.
- [0020] An inner cover plate (131) is seated upon the upper end of the cylindrical chamber wall (105) so as to provide a closed top surface of the upper chamber, extending within the interior of the cylindrical chamber wall (105). The inner cylindrical plate (131) also extends radially outwardly from the upper end of the cylindrical chamber wall (105). Thus, the upper chamber of the closed process chamber comprises an interior region formed below the inner cover plate (131) and within the cylindrical chamber wall (105).
- [0021] The lower chamber of the closed process chamber, which is larger than the upper chamber, is formed from below by a bottom plate (136). A frame (138) comprises

vertical walls which are joined about the periphery of the bottom plate (136) so as to form vertically extending sidewalls of the lower chamber. A wafer loading and unloading access door (134) is provided within one wall of the frame (138) and a maintenance access door is provided within another wall of the frame (138).

[0022] Opposite the bottom plate (136), the frame (138) is joined to an inwardly extending annular cover plate (132), so as to form an annular top surface of the lower chamber. Thus, the lower chamber of the closed process chamber comprises an interior region formed above the bottom plate (136), within the frame (138) and below the annular cover plate (132).

[0023] The annular cover plate (132) is seated at its inner peripheral edge against the horizontally extending flange of the lower end of the cylindrical chamber wall (105), so as to join the upper and lower chambers to form the closed process chamber.

[0024] A ring chuck (102) is located within the upper chamber. Ring chuck (102) is adapted to rotatably support a wafer (W). Preferably, ring chuck (102) comprises a rotatable drive ring having a plurality of eccentrically movable gripping members for selectively contacting and releasing the peripheral edge of a wafer.

[0025] In the embodiment shown in Figures 1a and 1b, the ring chuck (102) comprises a ring rotor (103) provided adjacent to the interior surface of the cylindrical chamber wall (105). A stator (104) is provided opposite the ring rotor adjacent the outer surface of the cylindrical chamber wall (105). The rotor (103) and stator (104) serve as a motor by which the ring rotor (and thereby a supported wafer) may be rotated through an active magnetic bearing. For example, the stator (104) can comprise a plurality of electromagnetic coils or windings which may be actively controlled to rotatably drive the ring chuck (102) through corresponding permanent magnets provided on the rotor (103). Axial and radial bearing of the ring chuck (102) may be accomplished also by active control of the stator or by permanent magnets. Thus, the ring chuck (102) may be levitated and rotatably driven free from mechanical contact. Alternatively the rotor may be held by a passive bearing where the magnets of the rotor are held by corresponding high-temperature-superconducting magnets (HTS-magnets) that are circumferentially arranged on an outer rotor outside the chamber. With this alternative embodiment each magnet of the ring rotor is pinned to its corresponding HTS-magnets of the outer rotor. Therefore the inner rotor makes the same movement as the outer rotor without being physically connected.

[0026] The inner cover plate (131) is perforated by a medium inlet (110). Similarly, the bottom plate (136) is perforated by a medium inlet (109). During processing of a wafer, processing fluids may be directed through medium inlet (109) and/or (110) to a rotating wafer in order to perform various processes, such as etching, cleaning, rinsing, and any other desired surface treatment of the wafer undergoing processing.

- [0027] The ring chuck (102) includes a trailing edge (122) which is oriented at a downward angle directed radially outward from the rotational axis of the ring chuck (102). Thus, centrifugal action created by a spinning wafer causes excess process fluid, which has been dispensed through medium inlet (109) or (110), to be driven against an angled surface of the ring chuck (102) and directed in a downward and outward direction from the trailing edge (122).
- [0028] Within the lower chamber of the closed process chamber, one or more vertically movable splash guards (111, 115) are provided. In Figure 1b two circular splash guards (111 and 115) are shown although it will be appreciated that any desired number of splash guards may be provided and are contemplated by this disclosure, the actual number of splash guards depending in part upon the number of different process fluids which are intended to be separately collected.
- [0029] The outer splash guard (111) is positioned concentrically about the inner splash guard (115). Thus, the inner splash guard (115) defines an inner process fluid collector within its interior. An outer process fluid collector is defined by an annular region formed between the outer surface of the inner splash guard (115) and the inner surface of the outer splash guard (111).
- [0030] Associated with each such fluid collector a drain is provided for delivering collected process media from the respective fluid collector to outside the closed process chamber. As shown in Figure 1b, drain (117) extends through the base plate (136) and opens to the inner fluid collector, while drain (108) extends through the base plate (136) and opens to the outer fluid collector. Preferably, base plate (136) is slanted relative to a horizontal plane toward each of the drains (108) and (117), such that fluid that is collected by the inner or outer fluid collector is caused to flow along the base plate (136) toward the drains (117) and (118).
- [0031] As shown in Figure 1a, an exhaust opening (106) leading to the closed process chamber also is provided to facilitate the flow of air and/or other gases and fumes.
- [0032] Each splash guard is independently movable in the vertical direction. Accordingly, each splash guard can selectively be raised and/or lowered relative to the ring chuck (102), and relative to any other splash guard, such that excess process fluid emanating from the trailing edge of the ring chuck (122) is directed toward a selected fluid collector.
- [0033] In Figure 1c, the outer splash guard (111) is depicted in an elevated status relative to the inner splash guard (115), such that excess process fluid emanating from the trailing edge (122) of the ring chuck (102) is directed against the inner surface of the outer splash guard (111) and into the outer fluid collector. Thus, excess fluid from the surface of a wafer undergoing processing can be selectively recovered through drain (108) and optionally recycled or reused.

- [0034] Preferably, and as shown in Figure 1c, the outer splash guard can be elevated a distance such that an inwardly facing upper lip is seated against the annular cover plate (132). In this position, the regions of the closed process chamber outside of the fluid collector are less exposed to any aggressive or caustic fumes derived from the process fluid being collected.
- [0035] In Figure 1e, the inner splash guard (115) is depicted in an elevated status, such that excess process fluid emanating from the trailing edge (122) of the ring chuck (102) is directed against the inner surface of the inner splash guard (115) and into the inner fluid collector. Thus, excess fluid from the surface of a wafer undergoing processing can be selectively recovered through drain (117) and optionally recycled or reused.
- [0036] Preferably, and as shown in Figure 1e, the inner splash guard can be elevated a distance such that an inwardly facing upper lip is sealed against the trailing edge (122) of the ring chuck (102). In this position, the regions of the closed process chamber outside of the fluid collector are less exposed to any aggressive or caustic fumes derived from the process fluid being collected. It will further be appreciated that, when the inner splash guard is elevated to facilitate collection of excess process fluid in the inner fluid collector, the outer splash guard can also be elevated so that protection of the regions of the closed process chamber outside of the fluid collectors from any aggressive or caustic fumes or fluids may be enhanced, as depicted in Figure 1d.
- [0037] Accordingly, by selective vertical movement of one or more splash guards, different process fluids can at different times be isolated and separately recovered from the closed process chamber. Thus, for example, process chemicals such as acids, bases and oxidizing liquids may each be recovered separately and without unnecessary dilution by other process fluids such as etching, cleaning or rinsing liquids, as well as gases.
- [0038] Still referring to Figures 1a-1e, one or more actuators are provided outside of the closed process chamber in order to facilitate the selective and independent movement of each splash guard. For example, in Figure 1a, an actuator (113) is operatively associated with the outer splash guard (111) and another actuator (116) is operatively associated with the inner splash guard (115). Preferably three actuators as provided for each splash guard, although the number of actuators used will depend in part upon the geometric shape of the associated splash guard.
- [0039] Actuators (113, 116) are provided with permanent magnets which correspond with permanent magnets carried by the splash guards (111, 116). Thus, selective vertical movement of each splash guard can be provided by the actuators through magnetic couples formed by the opposing sets of permanent magnets.
- [0040] In Figures 1f and 1g, modified splash guards (115a and 111a) are shown. In this embodiment, the outer splash guard (111a) includes an inwardly extending upper surface which overlies and engages an upper edge of the inner splash guard (115a) when the

inner splash guard (115a) is elevated. Thus, the outer fluid collector can be essentially sealed by the inner splash guard (115a) when the inner fluid collector is in use.

[0041] Figures 1f and 1g also show further details of an embodiment of the actuator for each splash guard within the closed process chamber. In this embodiment, with respect to the inner splash guard 115a), a piston (1160) is selectively driven by a lifting mechanism (116a) which can be, for example, a ball spindle or pneumatic lifting cylinder. The piston (1160) extends through an aperture in the bottom plate of the closed process chamber. Within the closed process chamber, the piston (1160) is covered by a cylinder shaped cover (1162), which cylinder shaped cover (1162) is sealed at its end distal to the bottom plate by a cylinder cap and is sealed at its end proximal to the bottom plate against an inner surface of the closed process chamber.

[0042] An inner magnet (1164) is attached to the piston (1160) and located in operative association with an outer ring-shaped magnet (1166) that is attached to the splash guard (115a). The inner magnet (1164) and outer ring-shaped magnet (1166) correspond to each other so that when the piston (1160) is raised or lowered by the lifting mechanism (116a), the splash guard (115a) is raised or lowered in a corresponding manner.

[0043] Another embodiment of the invention is depicted in Figures 2a-2d in which the functionality of the vertically movable splash guards is replaced with a mechanism for selective vertical movement of the ring chuck.

[0044] In this embodiment, a closed process chamber is defined by an interior region bounded by an upper plate (231), a lower plate (234) and a cylindrical chamber wall (215) which extends vertically between opposing surfaces of the upper plate (231) and lower plate (234).

[0045] A magnetically coupled and driven ring chuck (202) adapted to support a wafer (W), via a plurality of eccentrically movable pins (223), is located within the interior of the cylindrical chamber wall (215). A rotor (203) associated with the ring chuck (202) is located adjacent the interior surface of the cylindrical chamber wall (215) and is operatively associated with a corresponding stator (204), which is located adjacent the exterior surface of the cylindrical chamber wall (215). Stator (204) is carried by a carrier plate (237).

[0046] A chamber bottom (207) is located within the closed process chamber on the interior surface of the lower plate (234). The chamber bottom (207) accommodates a plurality of process fluid collectors provided as concentric annular ducts (208-209), each leading to a corresponding outlet (218-219) which extends from the annular duct to outside the closed process chamber. Preferably, each annular duct is slanted relative to the horizontal such that any process fluid collected therein is delivered to the corresponding outlet. The chamber bottom (207) also accommodates an annular exhaust duct (210) and corresponding exhaust outlet (220).

- [0047] Apertures (205 and 211) are provided in the upper plate (231) and plate bottom (207) such that process fluid may selectively be delivered to either or both sides of a spinning wafer undergoing processing.
- [0048] In this embodiment, the stator (204) and carrier plate (237) are mounted so as to be vertically movable relative to the cylindrical chamber wall (215). Accordingly, vertical movement of the stator (204) causes, via a magnetic couple with the rotor (203), a corresponding vertical movement of the ring chuck (202) and a wafer being held thereby. Selective vertical movement of the stator (204) is provided by actuators (206).
- [0049] The ring chuck (202) includes a trailing edge (222) which is oriented at a downward angle directed radially outward from the rotational axis of the ring chuck (202). Thus, centrifugal action created by a spinning wafer causes excess process fluid, which has been dispensed through medium inlet (205) or (211), to be driven against an angled surface of the ring chuck (202) and directed in a downward and outward direction from the trailing edge (222).
- [0050] In use, the stator (204) is positioned at a selected elevation relative to the cylindrical chamber wall (215), such that the ring chuck (202) is positioned at a corresponding elevation, which elevation is selected so that any excess fluid emanating from the trailing edge (222) will be directed into a desired annular duct.
- [0051] When a different process fluid is to be applied, the ring chuck (202) is moved in a vertical direction, via a corresponding vertical movement of the stator (204), to a position at which any excess fluid emanating from the trailing edge (222) will be directed into a different desired annular duct.
- [0052] In this manner, the ring chuck (202) may be selectively positioned in the vertical direction such that any given process fluid will be directed from the wafer to a selected annular duct and outlet, so that excess of each process fluid may be separately captured for recycling or reuse.
- [0053] While the present invention has been described in connection with various illustrative embodiments thereof, it is to be understood that those embodiments should not be used as a pretext to limit the scope of protection conferred by the true scope and spirit of the appended claims.

Claims

- [Claim 0001] Device for processing wafer-shaped articles, comprising a closed process chamber, a ring chuck located within said closed process chamber, and at least one process fluid collector in fluid communication through a bottom wall of the closed process chamber to the outside of the closed process chamber, wherein said ring chuck is adapted to be driven without physical contact through a magnetic bearing, and wherein said ring chuck and said at least one fluid collector are vertically movable relative to each other.
- [Claim 0002] The device according to claim 1, wherein the ring chuck is fixed in the vertical direction and the at least one process fluid collector comprises a vertically movable splash guard.
- [Claim 0003] The device according to claim 2, comprising a plurality of fluid collectors, each fluid collector comprising a vertically movable splash guard.
- [Claim 0004] The device according to claim 3, wherein each vertically movable splash guard is selectively driven from outside the closed process chamber to a predefined vertical position.
- [Claim 0005] The device according to claim 4, wherein each vertically movable splash guard is selectively positionable so as to capture a preselected process fluid emanating from a spinning wafer carried by said ring chuck.
- [Claim 0006] The device according to claim 5, further comprising a vertical movement actuator operatively associated with each vertically movable splash guard.
- [Claim 0007] The device according to claim 6, wherein said actuator is operatively associated with said vertically movable splash guard through a magnetic couple.
- [Claim 0008] The device according to claim 1, wherein the at least one process fluid collector is fixed in the vertical direction and the ring chuck comprises a vertically movable active magnetic bearing.
- [Claim 0009] The device according to claim 8, comprising a plurality of fluid collectors, said vertically movable active magnetic bearing comprising a vertically movable stator located outside the closed process chamber.
- [Claim 0010] The device according to claim 9, wherein said vertically movable active magnetic bearing is selectively positionable such that a preselected process fluid emanating from a spinning wafer carried by said ring

chuck is directed to a preselected fluid collector.

[Claim 0011] The device according to claim 10, further comprising a vertical movement actuator operatively associated said stator.

[Claim 0012] The device according to claim 11, wherein said vertical movement actuator is operatively associated with said stator through a magnetic couple.

[Claim 0013] The device according to claim 1, wherein the magnetic bearing is an active magnetic bearing.

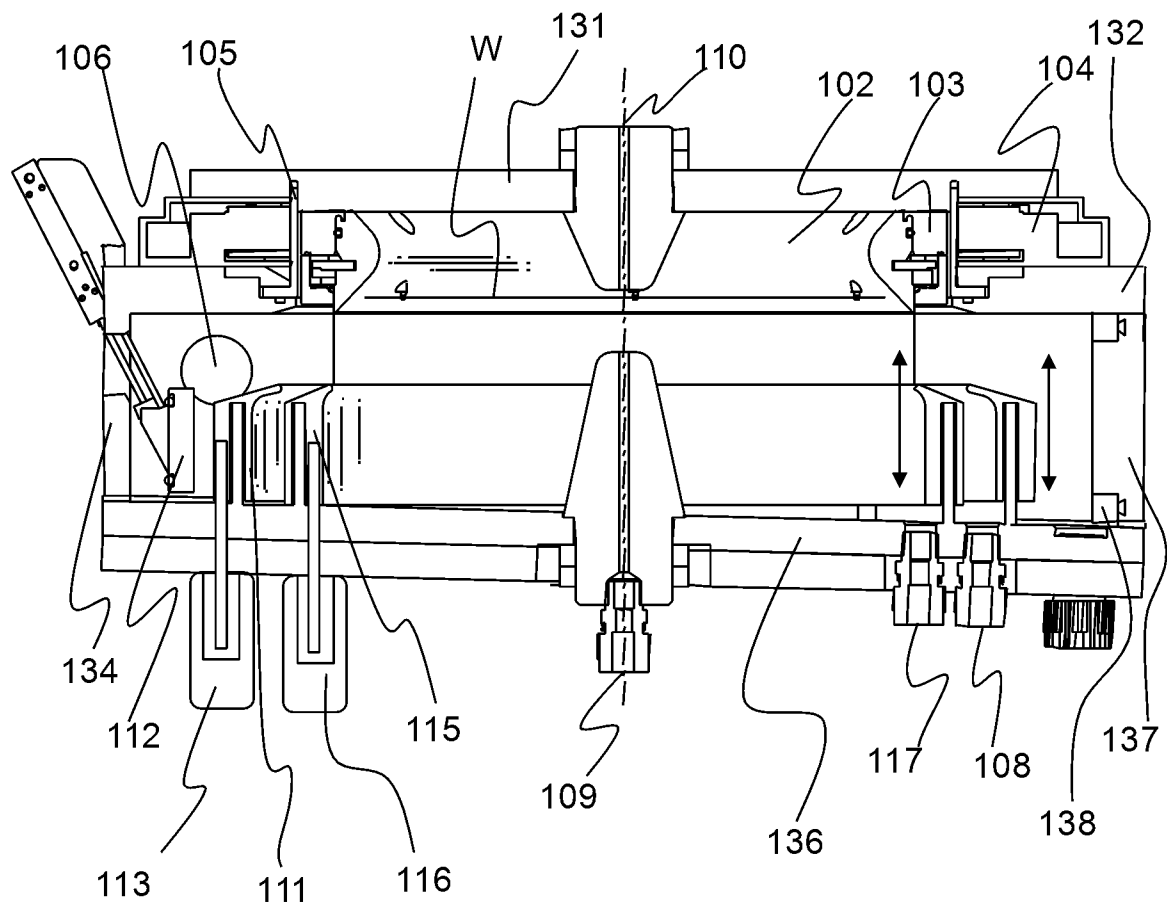


Fig. 1a

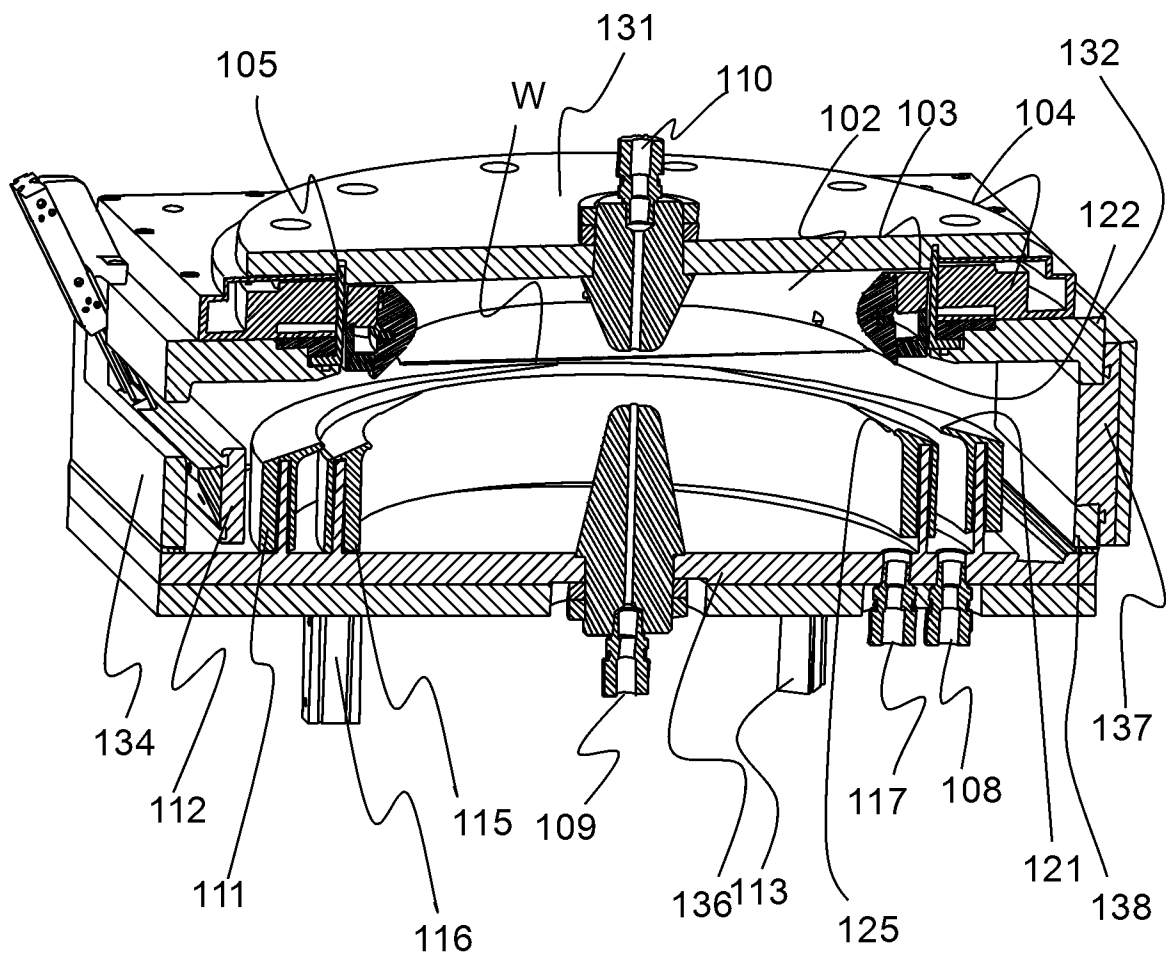


Fig. 1b

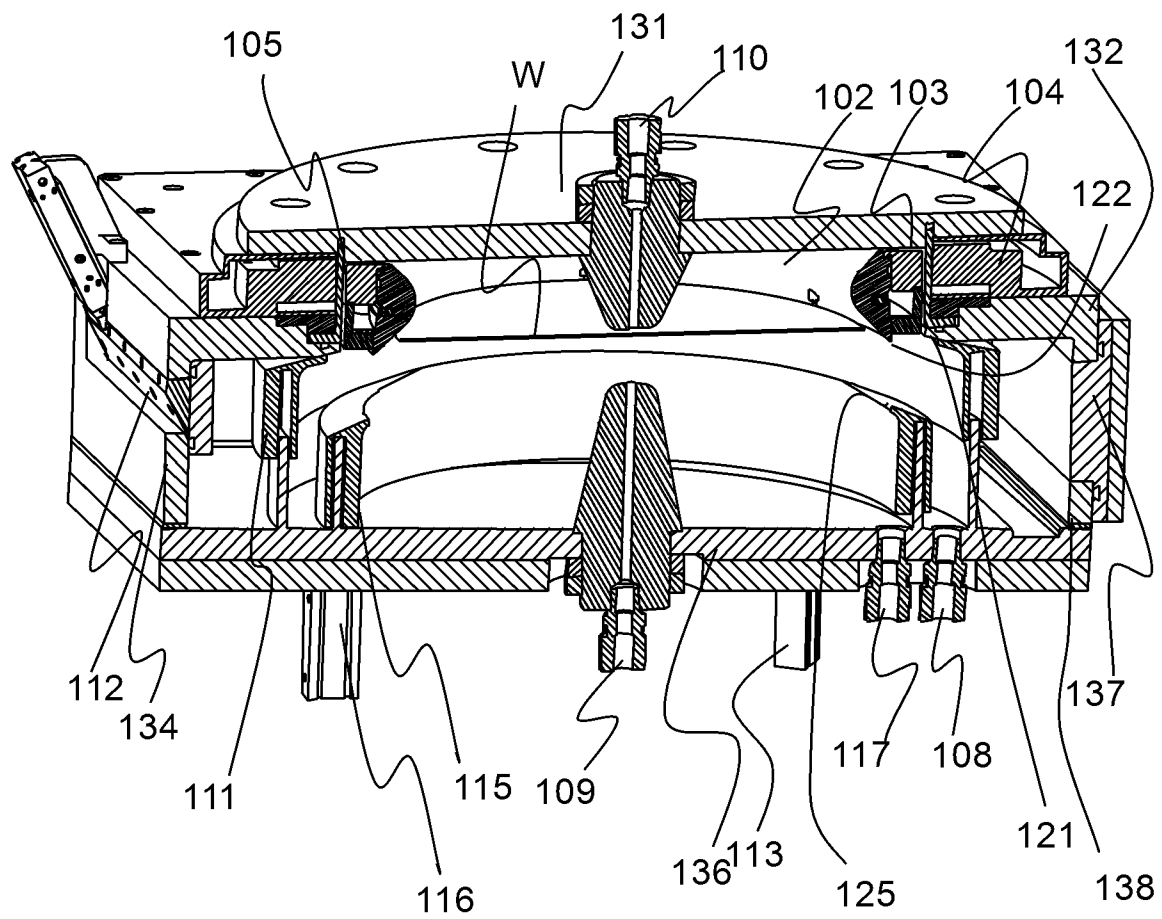


Fig. 1c

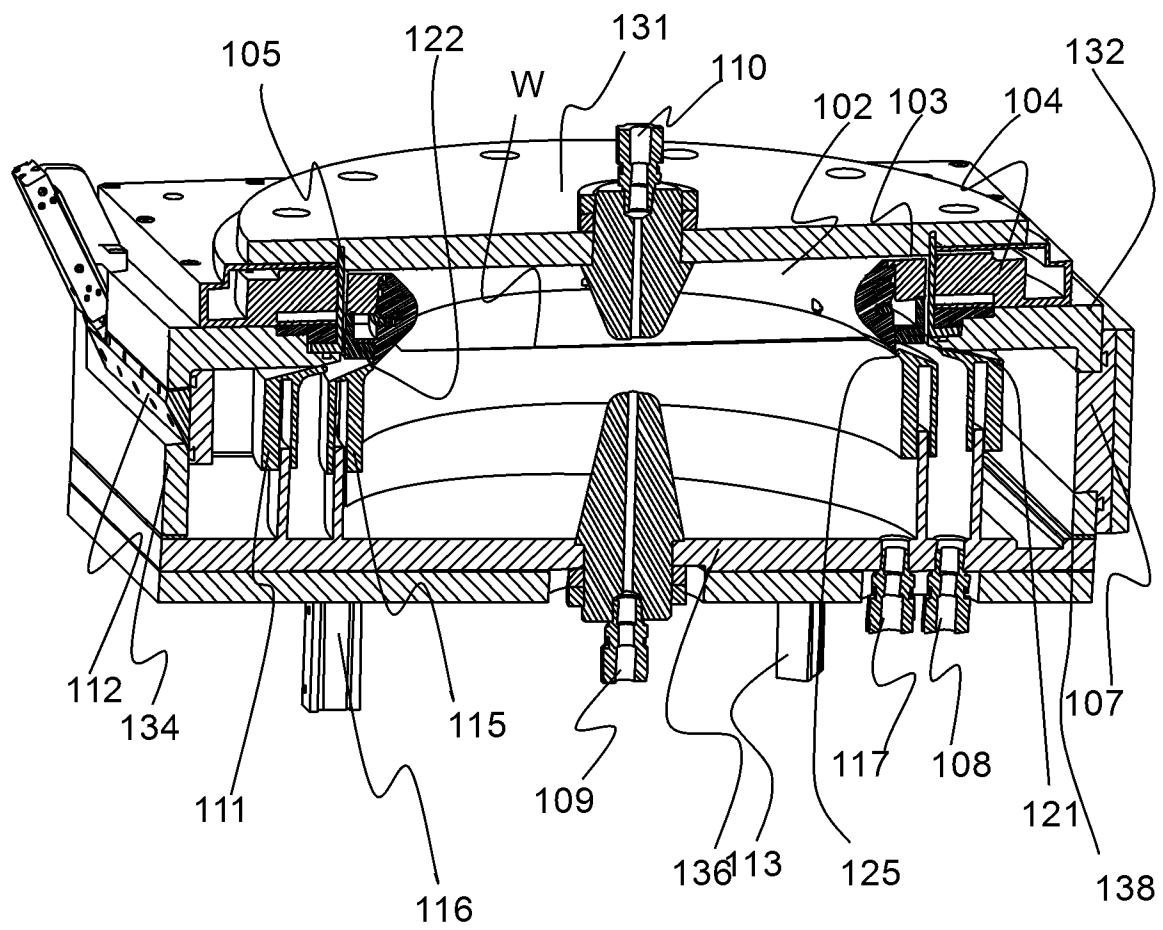
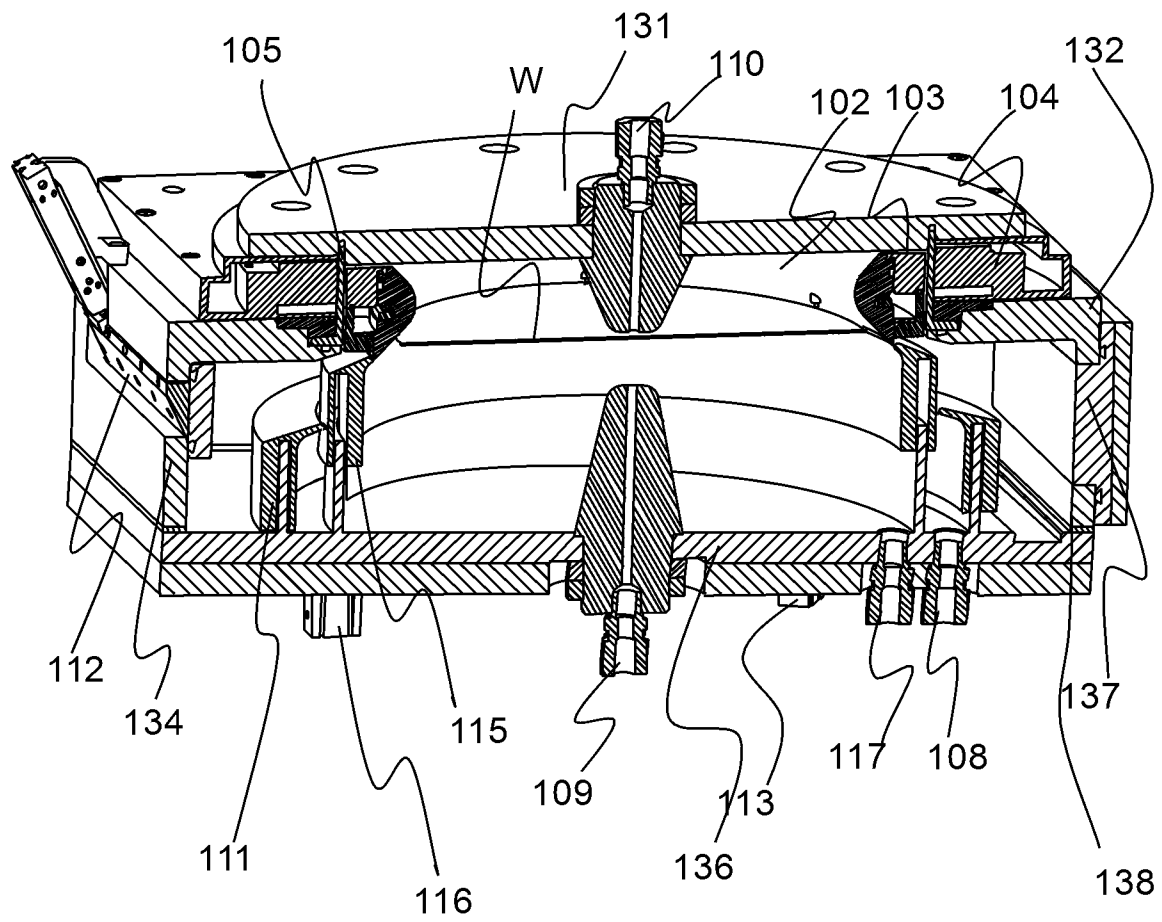


Fig. 1d

*Fig. 1e*

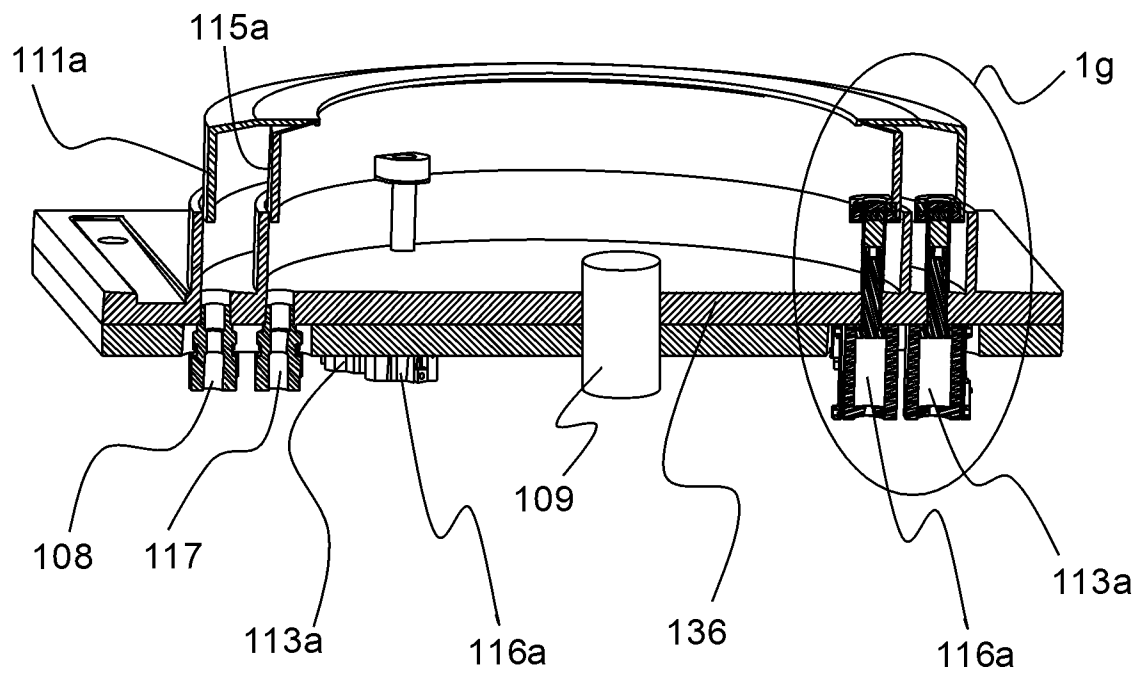


Fig. 1f

[Fig.]

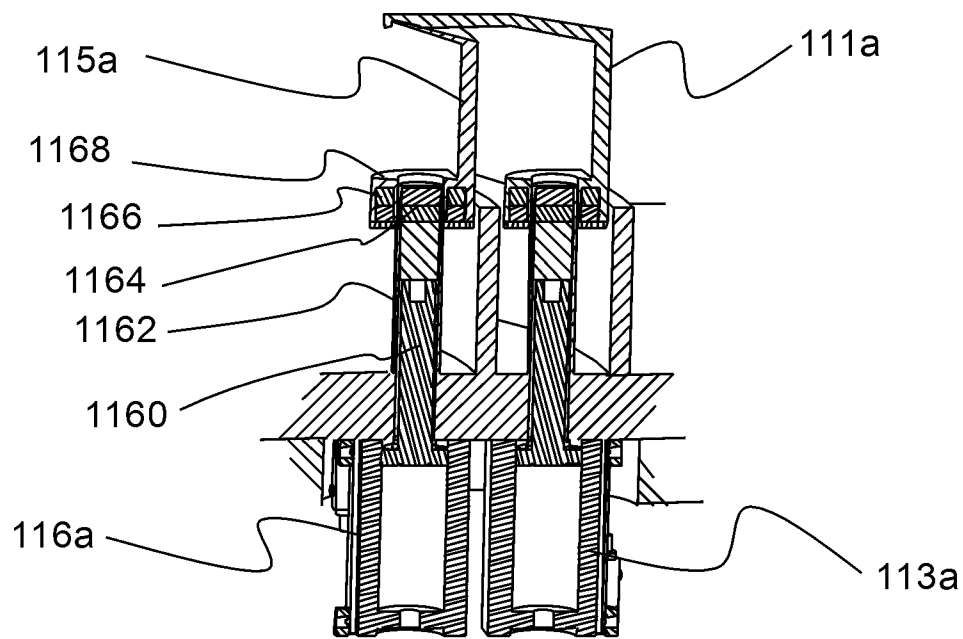


Fig. 1g

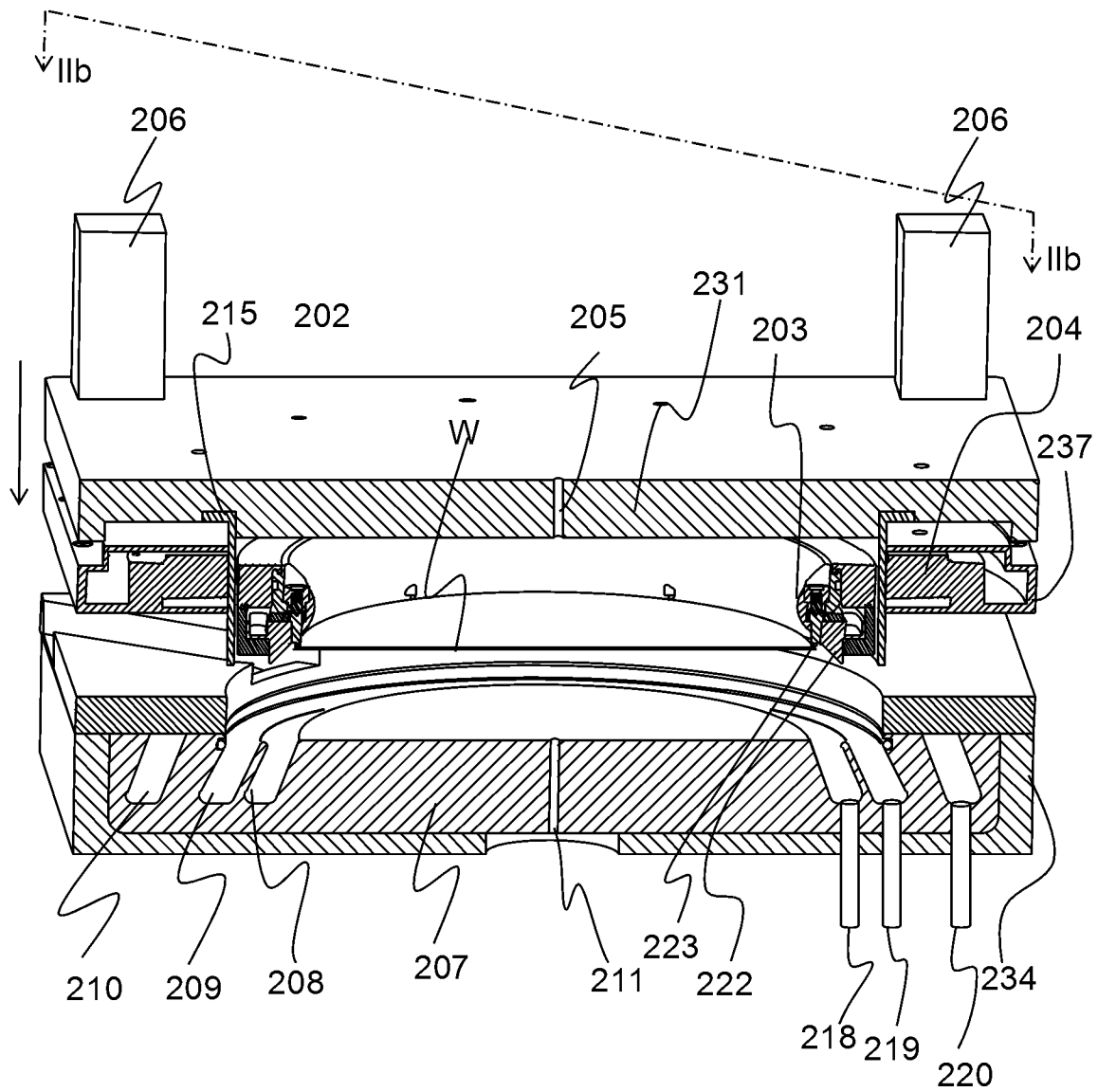


Fig. 2a

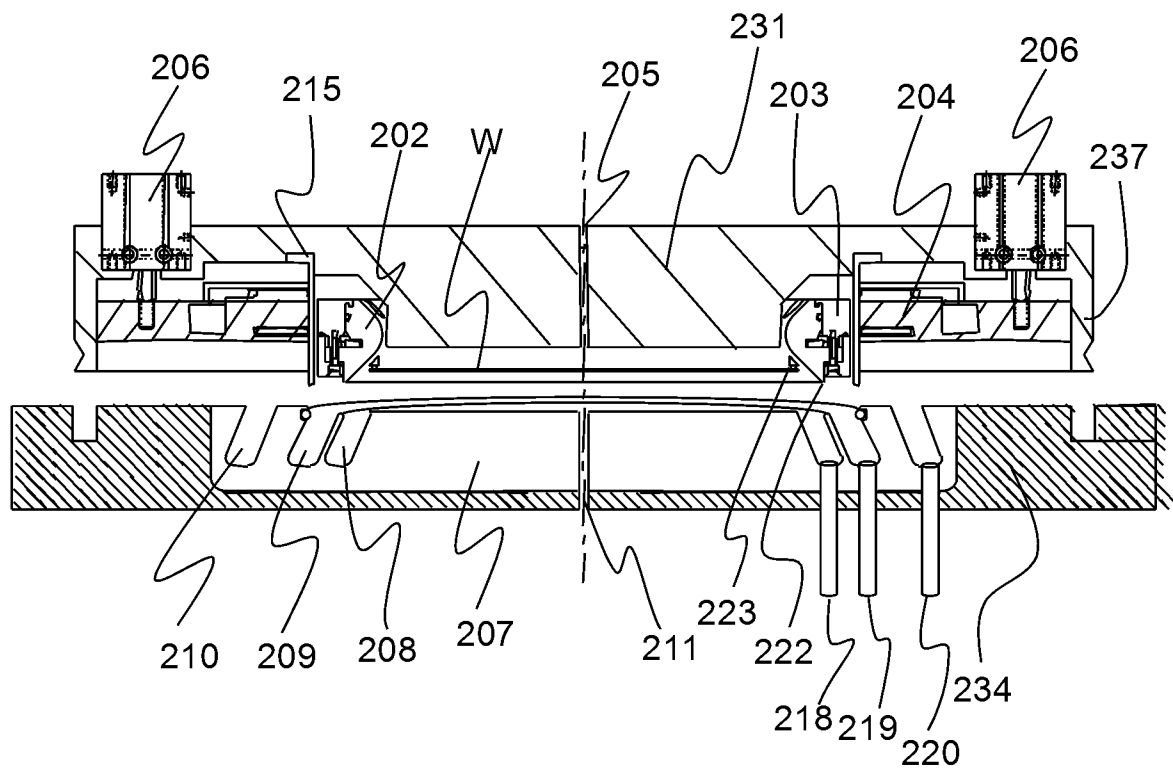


Fig. 2b

